

40V N-ch Power MOSFET

General Features

- Proprietary New Trench Technology
- > $R_{DS(ON),typ.}=2.5m\Omega@V_{GS}=10V$
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

Applications

- High efficiency DC/DC Converters
- Synchronous Rectification
- UPS Inverter

Ordering Information

Part Number	Package	Marking
MXP4004BF	TO-263-2L	MXP4004BF

Absolute Maximum Ratings

Symbol	Parameter	Value	Unit	
V _{DSS}	Drain-to-Source Voltage ^[1]	40	v	
V _{GSS}	Gate-to-Source Voltage	±20	V	
	Continuous Drain Current ^[2]	184		
I _D	Continuous Drain Current ^[3]	130	А	
-	Continuous Drain Current at T_c =100 °C ^[2]	130		
I _{DM}	Pulsed Drain Current at V _{GS} =10V ^[2,4]	736		
E _{AS}	Single Pulse Avalanche Energy $(V_{DD}=30V, V_{GS}=10V, R_G=25\Omega, L=1mH)$	435	mJ	
Р	Power Dissipation	204	W	
P_D	Derating Factor above 25°C	1.4	W/℃	
TL	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	°C	
T _J & T _{STG}	Operating and Storage Temperature Range	-55 to 175		

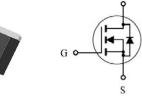
Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol Parameter		Min.	Тур.	Max.	Unit
R _{0JC} Thermal Resistance, Junction-to-Case				0.73	сw
R _{θJA}	Thermal Resistance, Junction-to-Ambient			63	0/11

BV _{DSS}	R _{DS(ON),max.}	I _D ^[2]
40V	3.0mΩ	184A





 $T_C=25^{\circ}C$ unless otherwise specified

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Electrical Characteristics

OFF Characteristics Symbol Parameter Min. Typ. Max.					Unit	Test Conditions	
Symbol			тур.	wax.			
BV_{DSS}	Drain-to-Source Breakdown Voltage	40			V	V_{GS} =0V, I _D =250uA	
I _{DSS}	Drain-to-Source Leakage Current			1	uA	V _{DS} =32V, V _{GS} =0V	
I _{GSS}	Gate-to-Source Leakage Current			±100	nA	V_{GS} =±20V, V_{DS} =0V	
ON Cha	racteristics				TJ =25 ℃	unless otherwise specified	
Symbol	Parameter	Min. Typ.		Max.	Unit	Test Conditions	
R _{DS(ON)}	Static Drain-to-Source On-Resistance		2.5	3.0	mΩ	V_{GS} =10V, I _D =130A ^[5]	
$V_{GS(TH)}$	Gate Threshold Voltage	2.0		4.0	V	V_{DS} = V_{GS} , I_D =250uA	
Dynami	c Characteristics	Es	sentially	independ	dent of op	erating temperature	
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
C _{iss}	Input Capacitance		4.29			V _{GS} =0V, V _{DS} =25V,	
C _{rss}	Reverse Transfer Capacitance		0.23		nF		
C _{oss}	Output Capacitance		0.72			f=1.0MHz	
R _g	Gate Series Resistance		1.2		Ω	f=1.0MHz	
Qg	Total Gate Charge		71			N/ 001/	
Q _{gs}	Gate-to-Source Charge		23		nC	V _{DD} =20V, I _D =80A, V _{GS} =10V	
Q_{gd}	Gate-to-Drain (Miller) Charge		18			10-00 , V $GS-10$ V	
Resistiv	e Switching Characteristics		Esser	ntially inde	ependent	of operating temperature	
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
t _{d(on)}	Turn-on Delay Time		19			V _{DD} =20V	
t _{rise}	Rise Time		19			$V_{DD}=20V$ $I_{D}=80A$ $V_{GS}=10V$ $R_{G}=2.5\Omega$	
t _{d(off)}	Turn-off Delay Time		46		ns		
t _{fall}	Fall Time		15		1		
Source-	Drain Body Diode Characteristic	cs	1	1	T J=25 ℃	unless otherwise specified	
Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions	
I _{SD}	Continuous Source Current ^[2]			184	Α	Maximum Ratings	
V _{SD}	Diode Forward Voltage		0.9	1.2	V	I _S =80A, V _{GS} =0V	
t _{rr}	Reverse Recovery Time		46		ns	V _{GS} =0V	
Q _{rr}	Reverse Recovery Charge		78		nC	I _F =80A,di/dt=100A/μ	

Note:

[1] T_J=+25℃ to +175℃

[2] Silicon limited current only

[3] Package limited current

[4] Repetitive rating, pulse width limited by both maximum junction temperature.

[5] Pulse width≤380µs; duty cycle≤2%.



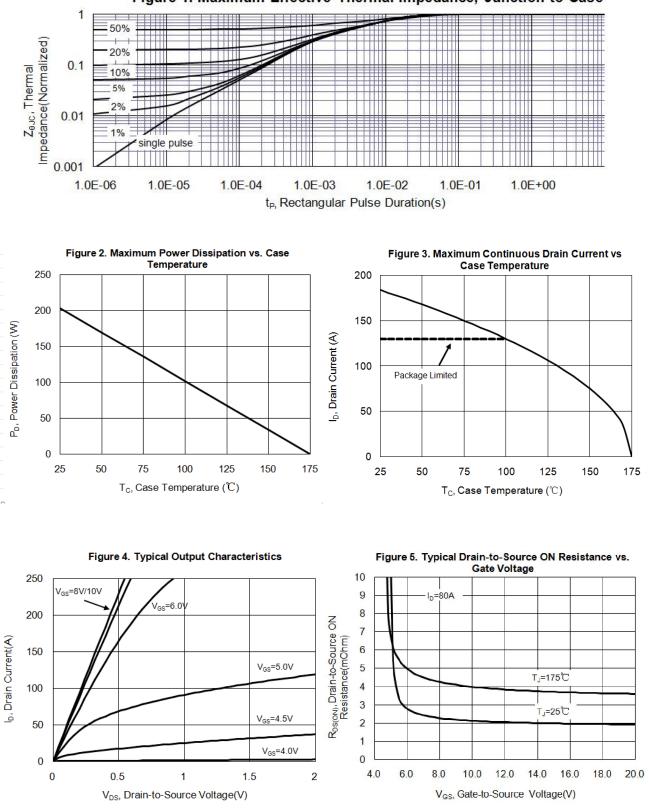


Figure 1. Maximum Effective Thermal Impedance, Junction-to-Case

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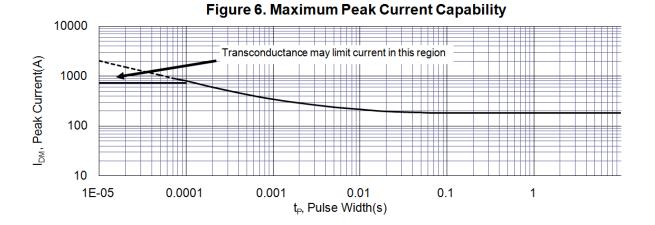
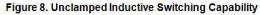
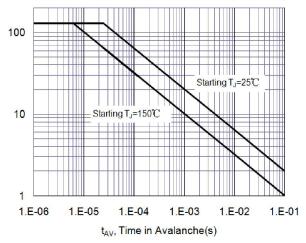
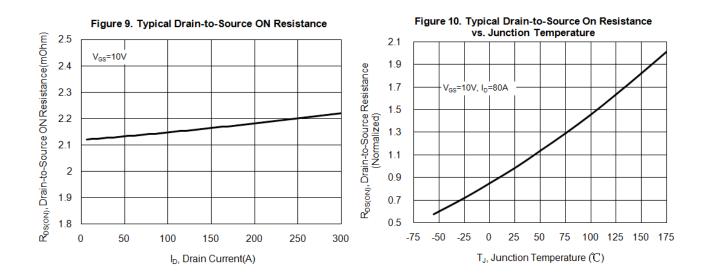


Figure 7. Typical Transfer Characteristics 400 V_{DS}=5V 350 **25℃** I_b, Drain-to-Source Current (A) AS, Avalanche Current(A) 300 250 200 150 175°C 100 50 0 2.00 3.00 4.00 5.00 6.00 V_{GS}, Gate-to-Source Voltage (V)

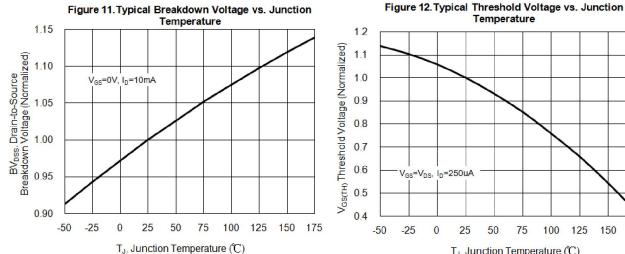






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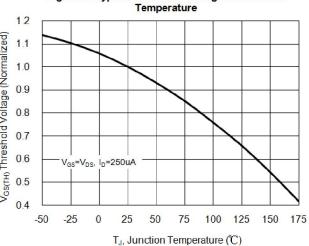


Figure 13. Maximum Forward Safe Operation Area

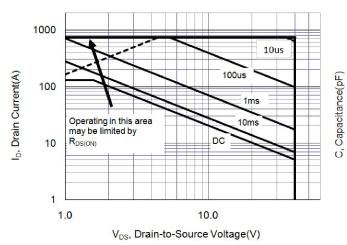
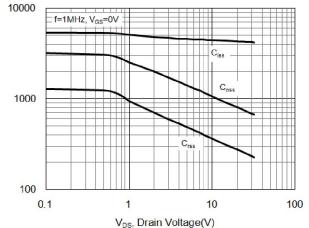
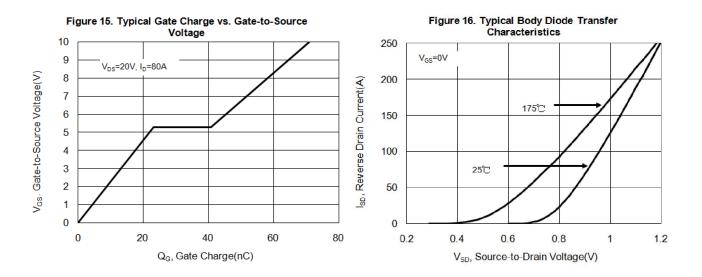


Figure 14. Typical Capacitance vs. Drain-to-Source Voltage

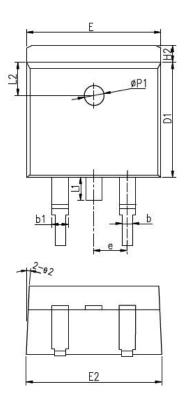


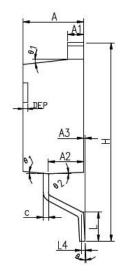


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TO-263-2L





COMMON DIMENSIONS

SYMBOL		MM		100	INCH		
STMDUL	MIN	NOM	MAX	MIN	NOM	MAX	
Α	4.40	4.57	4.70	0.173	0.180	0.185	
A1	1.22	1.27	1.32	0.048	0.050	0.052	
A2	2.59	2.69	2.79	0.102	0.106	0.110	
A3	0.00	0.10	0.20	0.000	0.004	0.008	
b	0.77	0.813	0.90	0.030	0.032	0.035	
b1	1.20	1.270	1.36	0.047	0.050	0.054	
С	0.34	0.381	0.47	0.013	0.015	0.019	
D1	8.60	8.70	8.80	0.339	0.343	0.346	
E	10.00	10.16	10.26	0.394	0.400	0.404	
E2	10.00	10.10	10.20	0.394	0.398	0.402	
e		2.54	BSC	0.100 BSC			
Н	14.70	15.10	15.50	0.579 0.594		0.610	
H2	1.17	1.27	1.40	0.046	0.050	0.055	
L	2.00	2.30	2.60	0.079	0.091	0.102	
L1	1.45	1.55	1.70	0.057 0.061		0.067	
L2	2.50 REF			3	0.098	REF	
L4		0.25 BSC			0.010 BSC		
θ	0°	5°	8°	0°	5°	8°	
61	5°	7°	9°	5°	7°	9°	
θ2	1°	3°	5°	1°	3°	5°	
ΦP1	1.40	1.50	1.60	0.055	0.059	0.063	
DEP	0.05	0.10	0.20	0.002	0.004	0.008	



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